

FDD7N25LZ N-Channel UniFETTM MOSFET 250 V, 6.2 A, 550 mΩ

Features

- $R_{DS(on)} = 430 \text{ m}\Omega \text{ (Typ.)} @ V_{GS} = 10 \text{ V}, I_D = 3.1 \text{ A}$
- Low Gate Charge (Typ.12 nC)
- Low C_{rss} (Typ. 8 pF)
- 100% Avalanche Tested
- Improved dv/dt Capability
- ESD Improved Capability
- RoHS Compliant

Applications

- LCD/LED/PDP TV
- Consumer Appliances
- Lighting
- Uninterruptible Power Supply
- AC-DC Power Supply

Description

UniFETTM MOSFET is Fairchild Semiconductor[®]'s high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

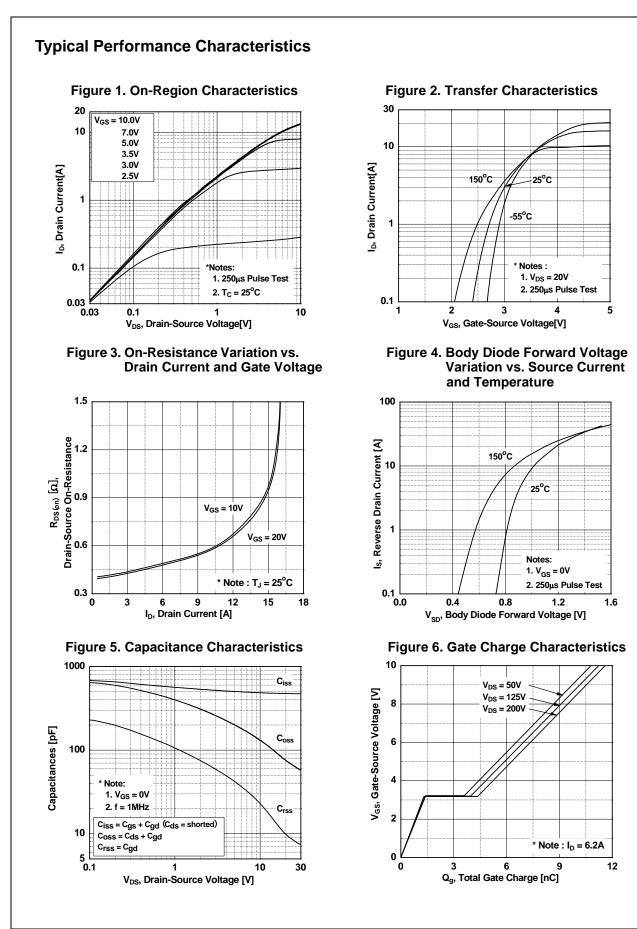
Symbol	Parameter			FDD7N20LZ	Unit	
V _{DSS}	Drain to Source Voltage			250	V	
V _{GSS}	Gate to Source Voltage			±20	V	
I _D	Droin Current	- Continuous (T _C = 25 ^o C)		6.2	^	
	Drain Current	- Continuous (T _C = 100 ^o C)		3.7	A	
I _{DM}	Drain Current	- Pulsed	25	А		
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	115	mJ	
I _{AR}	Avalanche Current		(Note 1)	5.5	Α	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	5.6	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	10	V/ns	
P _D	Devues Dissis eties	$(T_{\rm C} = 25^{\rm o}{\rm C})$		56	W	
	Power Dissipation	- Derate above 25°C		0.45	W/ºC	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

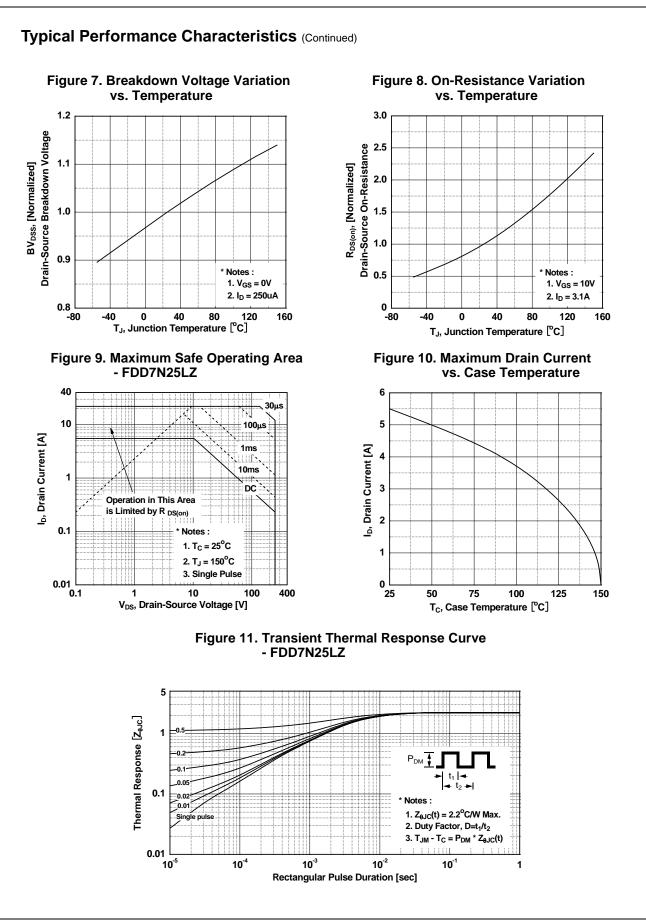
Symbol	Parameter	FDD7N20LZ	Unit
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	2.2	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient, Max.	110	°C/W

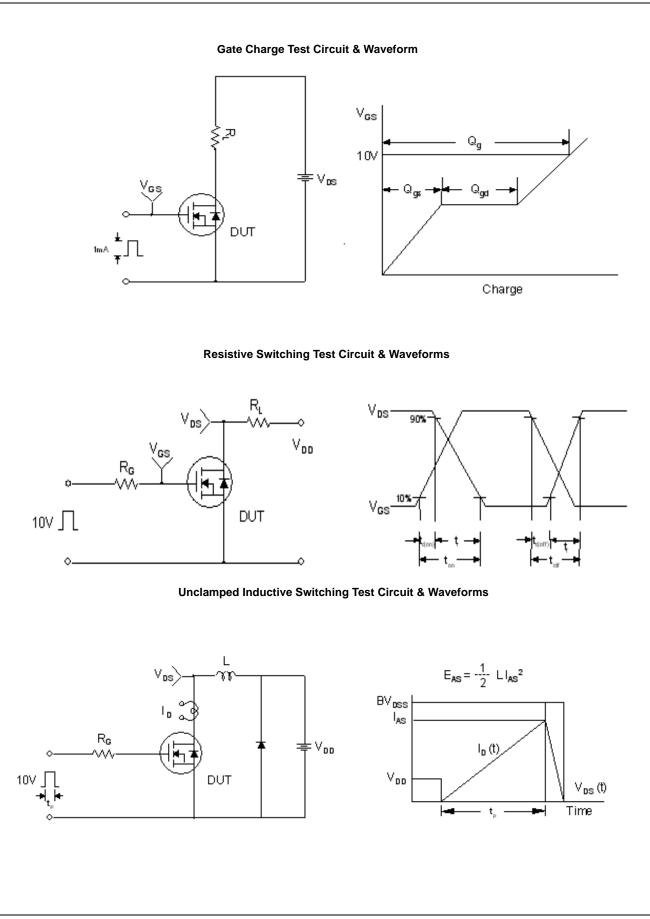
March 2013

FDD7N2	Device MarkingDevicePackaFDD7N25LZFDD7N25LZD-PA		ge	Reel Size	Тар	e Width		Quantit	y		
			<	380mm	1	6mm		2500			
Electrica	I Chara	acteristics T _c =	25°C unless	otherwis	se noted						
Symbol		Parameter			Test Conditions		Min.	Тур.	Max.	Unit	
Off Charac	teristics	5									
BV _{DSS}	Drain to	Source Breakdown V	oltage	ln = 25	ομΑ, V _{GS} = 0V, T _C =	= 25°C	250	-	-	V	
	BV _{DSS} Breakdown Voltage Temperature					0.05		N/00			
ΔT_J				$I_D = 250\mu A$, Referenced to $25^{\circ}C$		-	0.25	-	V/°C		
I _{DSS}	Zero Ga	te Voltage Drain Curr	ent	-	250V, V _{GS} = 0V		-	-	1	μA	
.032	Zero Gate Voltage Drain Current		-	200V, T _C = 125 ^o C		-	-	10	<i>pu</i> ,		
I _{GSSF}		Gate to Body Leakage Current, Forward			20V, V _{DS} = 0V		-	-	10	μA	
I _{GSSR}	Gate to	Body Leakage Curren	it, Reverse	$V_{GS} =$	-20V, V _{DS} = 0V		-	-	-10	μA	
On Charac	teristics	5									
V _{GS(th)}	Gate Th	reshold Voltage		V _{GS} =	V _{DS} , I _D = 250μA		1.0	-	2.0	V	
	Otatic D				10V, I _D = 3.1A		-	0.43	0.43 0.55		
R _{DS(on)}	Static Di	rain to Source On Res	sistance	$V_{GS} =$	5V, I _D = 3.1A		-	0.45	0.57	57 ^Ω	
9 _{FS}	Forward	Transconductance		$V_{\rm DS} = 20V, I_{\rm D} = 3.1A$			-	7	-	S	
)vnomio (horooto	riction									
Dynamic C								400	005		
C _{iss}	-	pacitance			V _{DS} = 25V, V _{GS} = 0V		-	480	635	pF	
C _{oss}	-	Capacitance		f = 1MHz		-	65	85	pF		
C _{rss}		Transfer Capacitance	3				-	8	12	pF	
Q _{g(tot)}		te Charge at 10V		V/ 250V/1 0.0A		-	-	12	16	nC	
Q _{gs}		Source Gate Charge		$V_{DS} = 250V I_D = 6.2A$ $V_{GS} = 10V$			-	1.5	-	nC	
Q _{gd}	Gate to	Drain "Miller" Charge		(Note 4)		-	4	-	nC		
Switching	Charact	eristics									
t _{d(on)}		Delay Time					-	10	30	ns	
t _r		Rise Time			250V, I _D = 6.2A		-	15	40	ns	
t _{d(off)}		Delay Time		$V_{GS} = 10V, R_{G} = 25\Omega$		-	75	160	ns		
t _f		Fall Time		_		(Note 4)	-	30	70	ns	
	T	le Characteristic									
l _S		n Continuous Drain to					-	-	5.5	A	
SM		imum Pulsed Drain to Source Diode Forward Current n to Source Diode Forward Voltage $V_{CS} = 0V$, $I_{SD} = 6.2A$			-	-	20	A V			
\/		Recovery Time	u voltage	$V_{GS} = 0V, I_{SD} = 6.2A$			-	-	1.4		
	Reverse	Recovery Time Recovery Charge			0V, I _{SD} = 6.2A = 100A/μs	-	-	130	-	ns	
V _{SD} t _{rr} Q _{rr}	Dovoroo			urF/ut -	- 100Αγμ3		-	0.6	-	μC	



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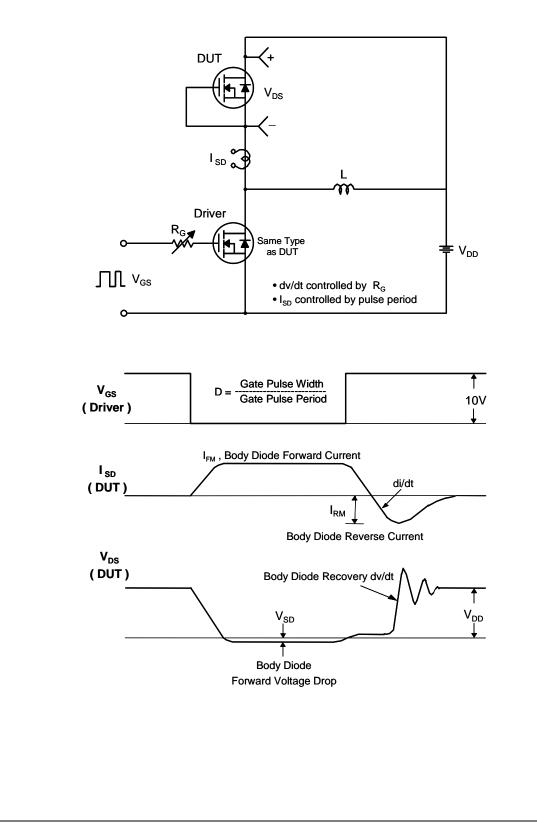


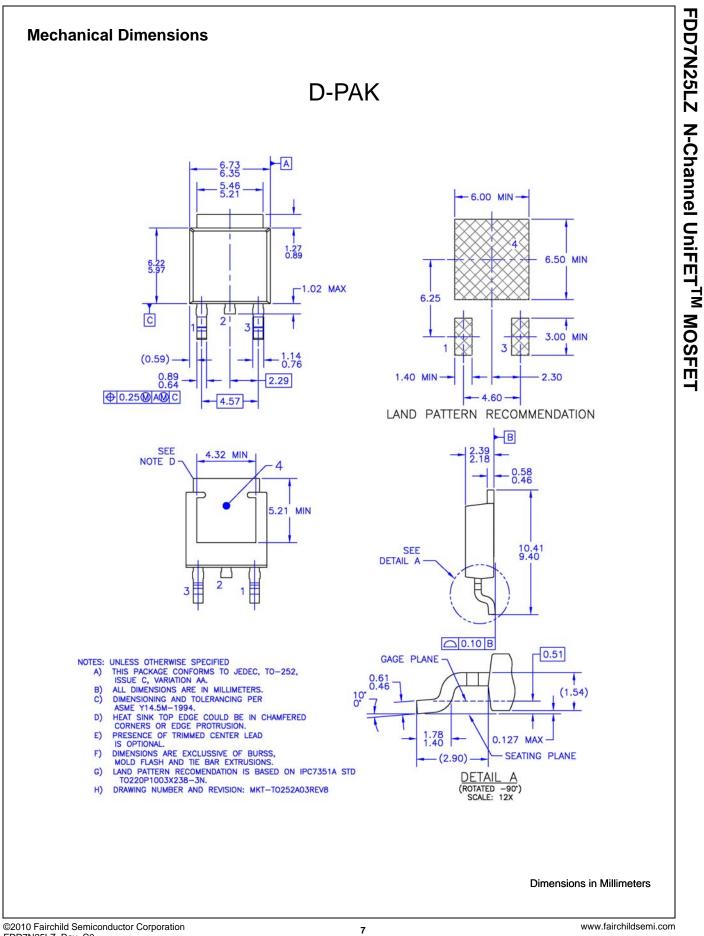
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Peak Diode Recovery dv/dt Test Circuit & Waveforms







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